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Photoconductivity of PbS/perovskite quantum dots in gold nanogaps†

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We demonstrate that the photoconductance of colloidal PbS/MAPbI₃ quantum dots in nanoscale gold electrode gaps shows a consistent power law dependence of the photocurrent on the light intensity with an exponent slightly below 0.7. The gap sizes are between 25 and 800 nm and by scanning photocurrent microscopy we evidence the strong localization and high reproducibility of photocurrent generation. We probe different flat-faced and pointed electrodes for excitation light in the red and near infrared spectral range and laser irradiances from 10⁻² to 10² W cm⁻². Our material combination provides practically identical photocurrent response for a wide range of gap sizes and geometries, highlighting its generic potential for nanoscale light coupling and detection.

1 Introduction

Miniaturizing active components to match the sub-micrometer dimensions of high-index waveguides, near field (*e.g.* plasmonic) structures or electronic components is a longterm challenge in photonics. Nanometer-sized colloidal semiconductor crystals (quantum dots, QDs) are an appealing choice in this context, being easily processable on a variety of substrates, including conventional semiconductor platforms. QDs are size-tunable in their quantized energy levels, they are strongly absorbing and show high quantum efficiencies.¹ Thin films of closely packed QDs are efficient photoconductors, *i.e.* they increase their conductivity due to carrier generation upon the absorption of light, a property that was intensely investigated due to its relevance for light detectors and photovoltaics. In particular, QD detectors have shown record spectral ranges and sensitivities and due to charge trapping quantum efficiencies well above unity can be achieved.^{2,3}

When combined with sub-micrometer spaced metal electrodes, photoconductive QDs form nanoscale light detectors. For CdSe/ZnS QDs between gold electrodes just a few nm apart, responsivities of a few tens of mA W⁻¹ (ref. 4) and light detection sensitivities of 500 fW (ref. 5) were reported. Crosstalk

between close electrodes was found to be suppressed due to the strongly confined electric fields in nanoscale gaps.⁶ Understanding the role of charge trap population⁷ and related memory effects⁸ contributed to the reproducibility of photocurrent generation in nanogaps. Gaps a few nm wide that are bridged by just one QD (but by many in parallel) were realized, showing sub-microsecond photocurrent response.⁹

The dynamics of photogenerated carriers is encoded in the photocurrent dependence on the exciton generation rate that is proportional to the level of light irradiance. In principle, a linear dependence of the photocurrent as a function of irradiance is expected for a large number of available charge traps, corresponding to one type of charge carrier (electron or hole) being trapped and the photoconductive gain being given by the ratio of trap time and transit time of the circulating carrier (*monomolecular* recombination). This usually applies for low irradiances, when just a fraction of available charge traps is filled. In contrast, a square-root-dependence (or *bimolecular* recombination) is expected for a low number of available charge traps (or high irradiances, when most trap centers are filled). Often, however, different exponents α in the power-law-dependence, photocurrent \propto irradiance ^{α} are observed. Although theoretical descriptions of photoconductance exist for many decades,^{10,11} the complex interplay of different trap types and the actual dynamics of carrier generation, transport and recombination makes it usually difficult to untangle the relative contributions. Exemplarily, power exponents of 1 and 0.5 were observed for lead-halide perovskite films for low and high irradiance, respectively.¹² For CdSe/ZnS QDs in nano- and microgaps, low-temperature measurements yielded an exponent of 1,^{7,13} while for room temperature a value of 0.8 was found.⁷ A similar value was observed for a ZnO nanowire upon UV illumination,¹⁴ while it was 0.45 for Mn doped ZnO nanowires under blue light

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illumination.¹⁵ PbS films showed exponents between 0.45–0.68, dependent on the fabrication process of the electrode/QD system.¹⁶

Within the wide choice of QD materials, perovskite-capped PbS received a lot of recent attention, as the size-tunable IR absorption of PbS QDs combines favorably with organometal halide perovskite shells as MAPbI₃ (ref. 17–21) for, first, further tunability of light absorption and emission.^{17,20,21} Second, with a view on photoconductance, perovskite shells of only about 1 nm thickness allow efficient charge transport between individual QDs in closely packed ensembles thereof.^{18,19,21}

In this Letter, we investigate PbS/MAPbI₃ QDs in nanoscale gaps defined by gold electrodes of varied geometries with mutual distances between 25 and 800 nm. For all sizes and different electrode geometries we observe quite similar power exponents of 0.60–0.69. We do not aim to untangle the detailed processes underlying the charge dynamics due to its multifaceted phenomenology. Rather, we show that the photocurrent response of our system is independent of electrode size and geometry. Therefore we image the QD-gaps by scanning photocurrent microscopy (SPCM), evidencing reproducible localized charge generation. We further evidence smallest detectable light levels around 100 fW (at 0.5 V bias) and deduce from our measurements maximum responsivities around 0.2 A W⁻¹. As a reproducible, stable and sensitive system, PbS/MAPbI₃ QDs in nanoscale gaps seem thus solid components in the context of nanoscale photodetection, optical switching and specific imaging applications.

2 Experimental

We fabricated gold electrodes with gap spacings between 25 and 800 nm (± 5 nm) and either flat or pointed (bow tie) geometries. By electron beam lithography, the electrode patterns were exposed in a poly(methyl methacrylate) resist layer on glass. After chemical development, a 3 nm thick chromium adhesion layer and a 30 nm thick gold layer were added by physical vapor deposition. Resist and excess metal were finally removed by chemical lift-off (see Methods for further details). The electric contact lines to the gaps are built in the same lithographic step, extending over a length of 500 μ m. Their corresponding widths depend on gap geometry and range from a few μ m to about 40 nm in the case of the nanoscale bow tie structures. The ends of the contact lines were in turn overlaid by millimeter-sized gold pads by shadow mask evaporation for contacting with metal pins to interface with the measurement circuitry. Applied bias voltages were in the range 0.01–10 V, photocurrents were measured with a transimpedance amplifier at 10¹⁰ or 10¹¹ gain and rise/fall times of 50 or 300 μ s, respectively. The measured photocurrents were typically in the pA range, with dark currents smaller than 5% of the photocurrent value.

3.1 nm large PbS colloidal QDs capped with lead oleate ligands were synthesized as described elsewhere.^{22,23} The procedure for phase transfer ligand exchange was adapted from our previous work.¹⁷ For all details, see the Methods section. Absorption and photoluminescence spectra of a QD solution (before ligand exchange) in 2,6-difluoropyridin are depicted in

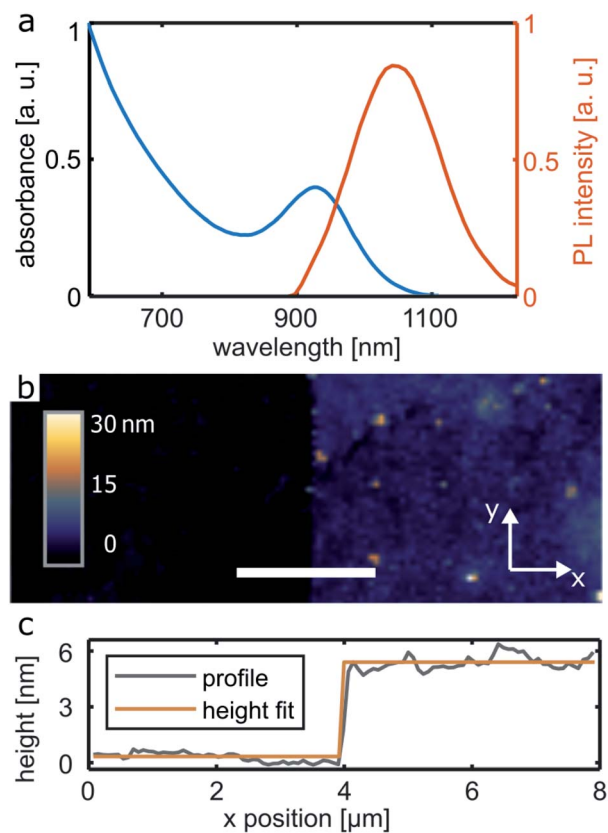


Fig. 1 PbS/MAPbI₃ QD spectra and film topography. (a) Absorbance and photoluminescence spectra in solution. (b) AFM image of a QD film edge induced by a mechanical scratch, the scale bar depicts 2 μ m, (c) height profile (grey line) averaged over the whole image in (b), the height fit (red line) gives an average height of 5.1 \pm 0.4 nm.

Fig. 1a. The PbS QD bandgap is size-dependent, the perovskite bandgap for MAPbI₃ is at 1.63 eV (760 nm).²⁴ The relative energy level values and thus the charge dynamics at the interface depends on the PbS QD size. The used PbS QDs display n-type transport behavior.²⁵

The QDs were deposited on the electrodes by spin coating a 10 mg mL⁻¹ solution in 2,6-difluoropyridin at 2000 rpm. The resulting films are 5.1 \pm 0.4 nm thick (corresponding to a QD monolayer), as measured by atomic force microscopy (AFM) on a mechanically induced scratch, see Fig. 1b. As evidenced by AFM and scanning electron microscopy (SEM), the QD films are rather homogeneous, with a few randomly distributed QD agglomerations of 15–150 nm in diameter at μ m separation distances.

As a powerful tool to image the spatial distribution of photocarrier generation and transport, scanning photocurrent microscopy (SPCM) relies on a focused laser beam that is scanned over an photoconductive sample, assigning the measured photocurrent to the respective laser position. This is in particular important for samples built from nanostructures, as it allows to assess the homogeneity of samples and to identify defects in the QD coverage. As shown in studies on CdSe/CdS QDs within μ m-spaced electrodes,



charge mobilities and transport pathways can be derived from SPCM measurements as well as local variations in light coupling to the sample.^{26,27} In our SPCM setup, we used a microscope objective with 40 \times magnification and 0.6 numerical aperture and a piezo stage for sample scanning. In parallel to the photocurrent measurement, an optical transmission image of the sample is acquired *via* a photodiode positioned behind the sample. For excitation, we used a supercontinuum laser emitting 6 ps pulses at 40 MHz repetition rate. Most experiments were done at an excitation wavelength of 650 nm, with further measurements at wavelengths at 600, 750 and 800 nm. In any case, the spectral bandwidth was 2.5 nm, selected by a volume holographic grating filter. For measuring the power dependence of the photocurrent, power levels in the nW to μ W range were applied, corresponding to light irradiances between 10^{-2} and 10^2 W cm $^{-2}$. The focus size was close to diffraction limited, as verified with measuring $1/e^2$ intensity value of a focused spot at 650 nm wavelength at a radius of 1.4 μ m, by monitoring the transmitted light intensity when scanning over the sharp edge of an opaque metal film. This is confirmed by the lateral profile of photocurrent maps taken from nanoscale gaps. All

SPCM measurements were done with a power of about 0.5 μ W and an irradiance around 15 W cm $^{-2}$.

3 Results and discussion

Sketches of the investigated electrode geometries are depicted in Fig. 2a. Largest gap sizes are 800 nm, while the smallest gaps measuring 25 nm are defined by a bow tie geometry. Individual gaps vary with ± 5 nm, actual values are given where the respective measurements are discussed. For the ease of fabrication, the QDs are spun over the whole sample and thus cover the whole substrate surface. As we find in any case by SPCM, the

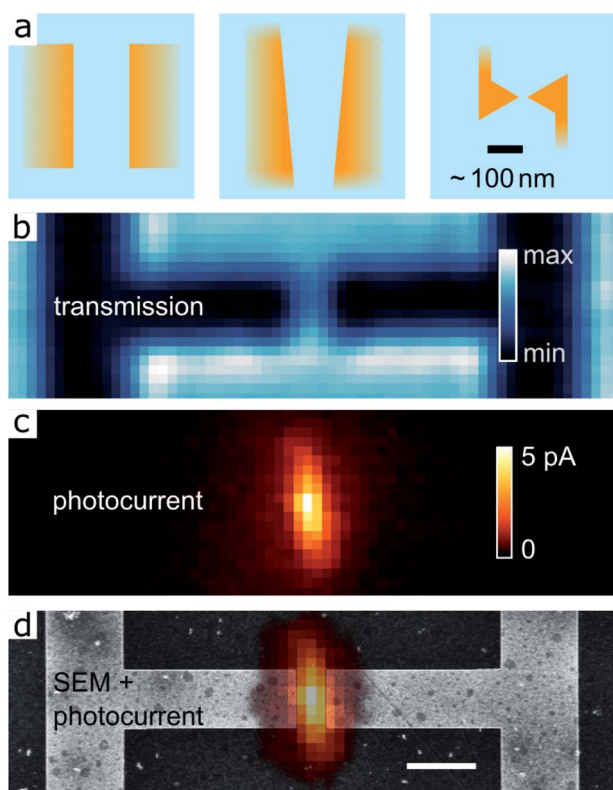


Fig. 2 Gap geometry and SPCM imaging of QD photocurrent generation. (a) Sketch of the gap geometries, the scale bar gives the approximate dimension. (b) Optical transmission image of a gold electrode gap of 800 nm, with a width of 1500 nm. (c) shows the SPCM image for an excitation wavelength of 650 nm and an applied bias of 100 mV. The image acquisition dwell time per pixel is 10 ms. (d) SEM image of the same sample region overlapped with the photocurrent image from (b); the scale bar depicts 2 μ m.

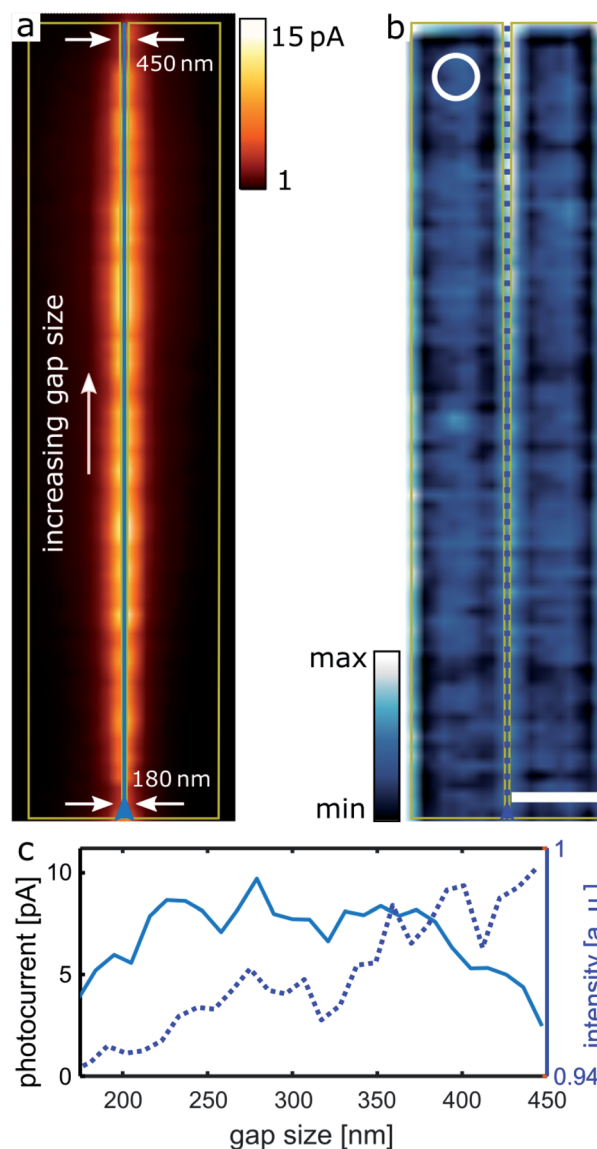


Fig. 3 SPCM imaging of QD photocurrent generation in a slit electrode with a varying size of 120 to 450 nm. (a) SPCM image for an excitation wavelength of 650 nm and an applied bias of 100 mV. (b) Optical transmission image. We note that the color scale has been optimized to make visible the transmission variation within the electrode slit. The white circle depicts the 1.4 μ m radius ($1/e^2$ value) of the focus. (c) Cross-cuts along the solid and dotted lines in (a) and (b), respectively. The scale bar in (b) depicts 5 μ m.



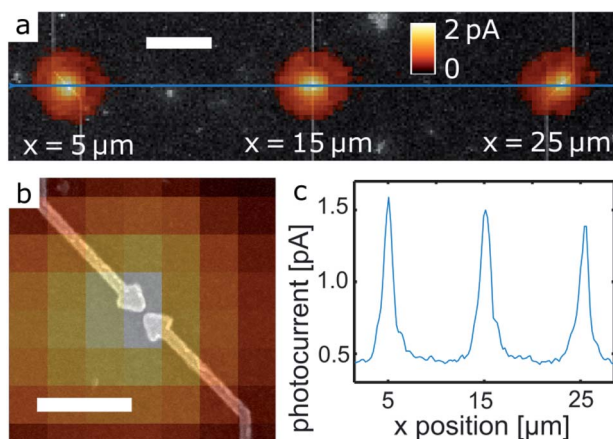


Fig. 4 SPCM imaging of QDs in bow tie nanogaps. SPCM overlapped to a SEM image of the same sample region including (a) three gaps and (b) one gap in higher magnification. (c) Photocurrent profile extracted along the blue line in (a). The excitation wavelength is 650 nm and the applied bias is 100 mV. The scale bar depicts in (a) 2 μm and in (b) 500 nm.

photocurrents are only generated when the exciting laser is positioned well within the gap region, which we attribute to the strong field localization generated by the electrodes and the correspondingly localized photocurrents.^{4,7} This is evidenced exemplarily for an 800 nm gap defined by electrodes with parallel edges 1500 nm wide, as visible in the transmission image in Fig. 2b. The SPCM image (at 0.1 V bias voltage) in Fig. 2c and its overlay with a SEM image (Fig. 2d, SEM taken after the SPCM measurement) illustrate the localized photocurrent generation, any apparent delocalization is compatible with the focus size.

The SPCM image of an electrode structure with a gap of varying size from 120 to 450 nm between two extended electrodes is shown in Fig. 3a. For this sample, the SPCM image shows a rather constant photocurrent along most of the slit, well confined to the gap region. The transmission image (Fig. 3b) and the corresponding cross-cut (Fig. 3c) shows that the transmission through the slit increases linearly with its size. The external quantum efficiency, which accounts for the variation of the absorptive cross section with the gap size, is shown

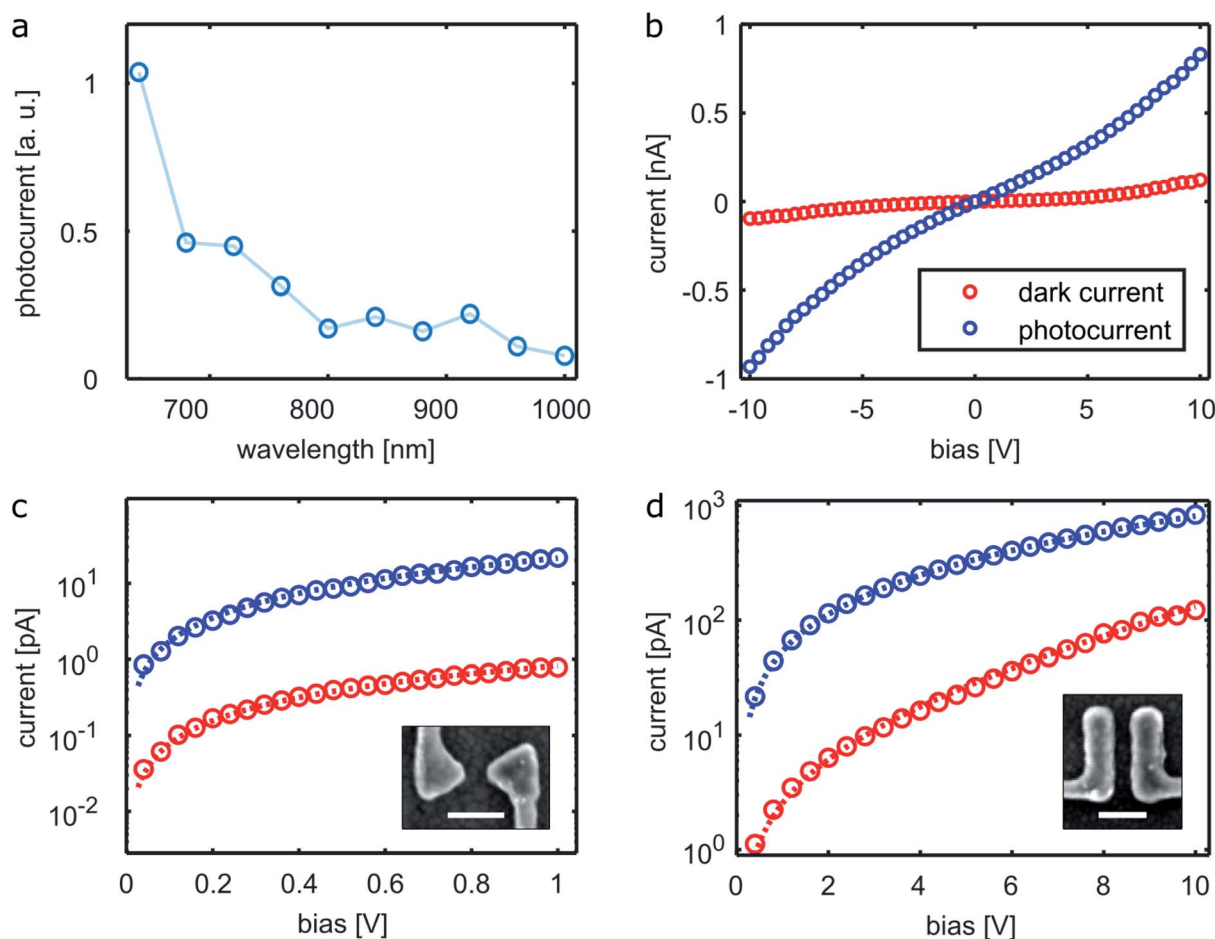


Fig. 5 PC dependencies on wavelength and bias. (a) Wavelength dependence. Gap voltage, laser power and irradiance are 100 mV, 0.6 μW and 9.5 W cm^{-2} , respectively. (b) I/V characteristics of a flat face gap (1.0 μW laser power, 1.8 W cm^{-2} irradiance), the blue curve shows the PC, the red curve depicts the dark current. The same data are logarithmically plotted in (d), (c) shows the data for a bow-tie gap (1.0 μW laser power, 8.1 W cm^{-2} irradiance) and (d) a flat face gap, the insets show SEM images thereof, the scale bar depicts 100 nm. The symbols show the measured data, the lines depict the model fit discussed in the text. The scale bars depict 100 nm.



in Fig. S1†. Gap-size-related resonance effects are thus not observed here.

We next turn to nanoscale gaps defined by bow tie geometries with a gap size of 25 ± 5 nm. In Fig. 4a, a SPCM image of three bow tie gaps is shown, overlaid to a SEM image. For all gaps we observe quite similar signals, highlighted by the cross section in Fig. 4c. The photocurrent generation is well restricted to a region that corresponds to the focus size,^{4,7} as further evidenced by the high magnification image in Fig. 4a. We emphasize that a 25 nm wide gap is bridged by a QD film that contains only five QDs between the electrode tips. While apart from the example in Fig. 4 very similar photocurrent levels have been observed for about ten further gaps we conclude that our fabrication procedure yields very homogeneous QD films with rather similar QD numbers also in very small gaps. In contrast, for non-optimized film fabrication (drop casting instead of spin coating, different QD solution concentrations) we observed as well QD multilayers or agglomerates in individual gaps, that led to strongly varying photocurrents. In addition, we hypothesize that the complete absence of photocurrent signals observed for three gaps is due to a highly localized void in the QD film, as discussed in the ESI (Fig. S2†).

We now characterize the photoconductive properties of our QD/gap structures more closely. For a bow-tie gap (gap size 40 nm), we plot in Fig. 5a the wavelength dependence of the photocurrent (for the correction of the chromatic aberration of the microscope objective see the Methods section). Besides the evident increase towards lower wavelength, we find a rather weak but clear signature above a wavelength of 900 nm, corresponding well to the lowest energy QD absorbance (Fig. 1a), evidencing QD absorption as the initial step in photocurrent generation.

For a flat gap with 40 nm size and 200 nm width, the bias voltage dependence of the photocurrent is plotted in Fig. 5b. We note that the bias voltages used here, up to 10 V, are significantly higher than used for the other experiments in this work, that operate within the rather linear current regime up to 1 V. From the I/V curve around zero bias we can estimate the contact resistance of the QDs to the gold, which is around 20 M Ω . The same data on a logarithmic scale are plotted in Fig. 5d. Fig. 5c shows the corresponding I/V curves for a bow-tie gap (40 nm size). In any case, the red curve depicts the dark current, the blue curve depicts the photocurrent.

The photocurrent can be phenomenologically described by²⁸

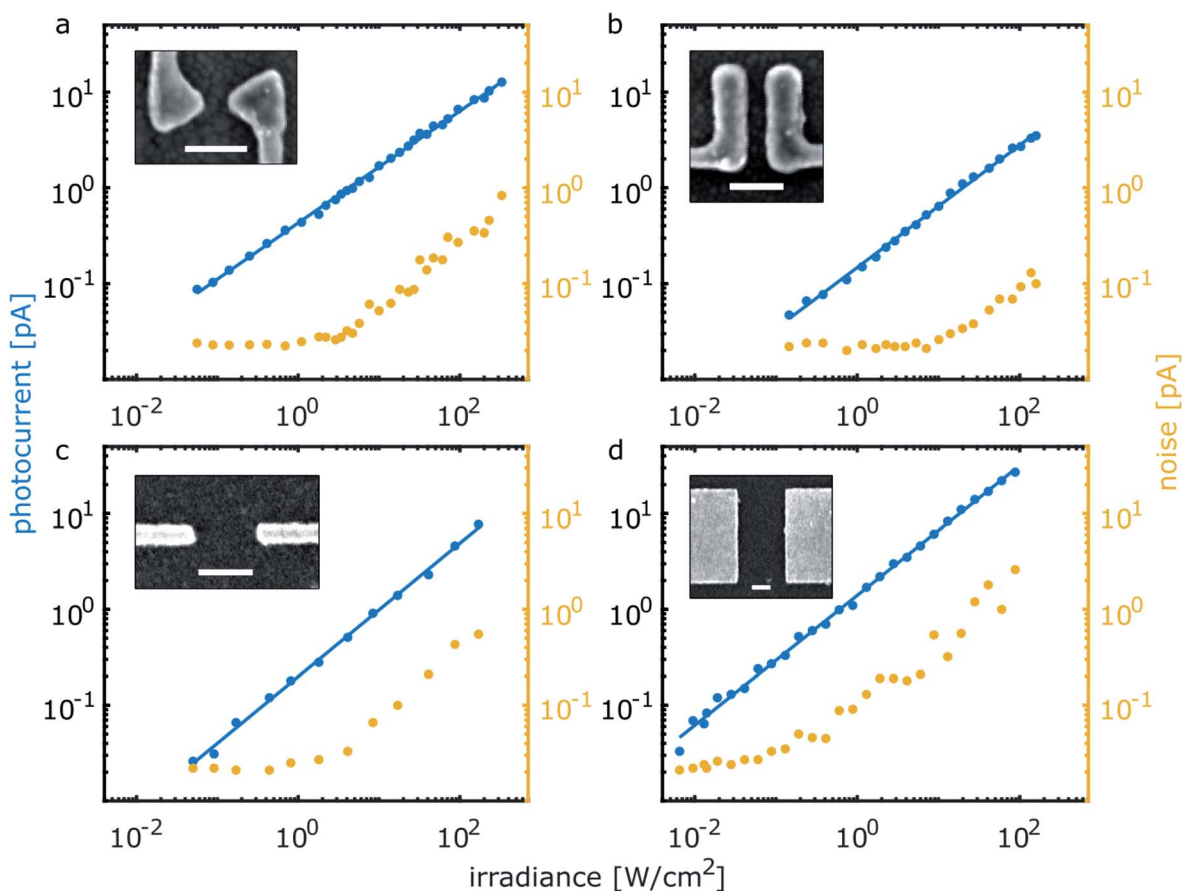


Fig. 6 PC and noise dependence on laser irradiance measured for the gaps shown in the inset SEM images. The blue symbols depict the measured photocurrent values, the blue lines are fits to the data yielding power law exponents of (a) 0.60, (b) 0.64, (c) 0.69, (d) 0.68. The yellow symbols show the corresponding signal/noise ratios. The scale bars depict 100 nm. Bias voltages for (a)–(d) are 0.5, 1.0, 0.2 and 0.2 V, respectively.



$$I_{\text{pc}} = \frac{V}{R_0} \exp\left(\frac{V}{V_0}\right). \quad (1)$$

The characteristic voltage barrier V_0 and the equivalent sheet resistance R_0 are about 5 V and 60 G Ω for the bow-tie gap and about 22 V and 10 G Ω for the flat gap, respectively. The average voltage drop per QD is thus 0.6 and 2.8 V, respectively, assuming a QD size of 5 nm. The high sheet resistance is to be expected for nanoscale electrodes, as compared to values in the M Ω range reported for laterally extended (interdigitated) electrodes.²⁶ Interestingly, the phenomenological model of the fit describes the data from the ultrasmall gaps very well, while the concept of sheet resistance has been suggested to fail when only a few QDs are bridging a gap.²⁶

The dependence of the photocurrent on the exciting light irradiance was measured for different gap geometries, as summarized in Fig. 6 (blue symbols), the gaps are depicted in the inset SEM images. The exciting light wavelength was 650 nm in all cases. All data can be very well described by a power law with rather similar exponents α ranging from 0.60 to 0.69. The irradiance dependence of the photocurrent is largely independent on wavelength and bias, as illustrated in the ESI (Fig. S3 and S4[†]). While untangling the multitude of factors that could contribute to this specific value of the power law exponent (with respect to the excitation, dissociation transport and recombination dynamics of the charge carriers) is beyond the scope of this paper, a likely significant contribution is a combination of mono- and bimolecular recombination. This is in fact to be expected for different electron and hole mobilities,²⁷ due to a resulting space charge layer giving rise to an exponent value of 0.75.²⁹ In addition, some role might be played by (fluctuating) percolation paths in our quasi-2D QD monolayer samples, giving rise to a nontrivial charge transport dynamics.^{30,31}

The lowest photocurrent value measured for an irradiance of 6 mW cm⁻² at 650 nm wavelength was about 20 fA (for a bias voltage of 0.5 V). The responsivity for the bow-tie gaps, taking the actual focus and gap sizes into account yields normalized values around 0.2 A W⁻¹. We note that we observed photocurrents as well at zero bias voltage, as depicted in the ESI (Fig. S5 and S6[†]).

Besides the photocurrent, we plot in Fig. 6 the corresponding noise (yellow symbols). The noise level is defined by the standard deviation of the static photocurrent, which is measured for five seconds for each irradiance value. For low irradiance levels noise is constant around 20 fA, to increase in proportion to the photocurrent for higher irradiances. On one hand, this can be due to fluctuating fields and conduction paths (transport noise), to be expected for nanoscale structures. On the other hand, charge generation and recombination noise that increases with irradiance can contribute.

4 Conclusion

We have shown that reproducible and stable nanoscale photoconductors in the red and near infrared spectral region can be fabricated with flat gold electrodes and PbS/MAPbI₃ QDs. For gaps with sizes of 25–800 nm and either flat or pointed

geometries, a power exponent around 0.60–0.69 was found for the irradiance dependence of the photocurrent over four orders of magnitude of light power. Importantly, nanoscale gaps enable the local measurement of light and/or light/matter coupling, as opposed to, *e.g.*, interdigitated electrodes that average over large areas. Given existing fabrication processes,⁹ even gaps with just a few nm across that host a single QD seem feasible. Those would not only realize the ultimate limit in the miniaturization of QD photodetection, but as well bring elementary processes in QDs within experimental reach, *e.g.*, single QD photocurrent and photoluminescence and the correlation of these two processes.¹² Finally, optical functionality in the electrodes could further enrich the fundamental and applied aspects involved, in particular by exploiting plasmonic resonances of the electrodes.³²

5 Methods

Electron beam lithography

For lithographic fabrication, we applied the beam of a scanning electron microscope to expose the electrode geometries in a 100 nm thick poly(methylmethacrylate) (PMMA) resist film on a cover slide glass substrate. An additional 60 nm thick layer of a conductive polymer (Allresist, AR-PC 5090) provided electric conductivity to prevent charging. After exposure, removal of the water-soluble conductive polymer layer and chemical development of the PMMA mask, we deposited a 3 nm thick chromium adhesion layer (rate 0.1 nm s⁻¹) and a 30 nm thick gold layer (rate 1 nm s⁻¹) by physical vapor deposition. Chemical lift-off with acetone removed the PMMA mask together with excess metal.

Quantum dot synthesis

Briefly, Pb(CH₃COO)₂ × 3H₂O (1.5 g, 4 mmol), ODE (47.5 mL) and oleic acid (2.5 mL, 7 mmol) were mixed in a 100 mL three-neck flask. The mixture was degassed under vacuum at 120 °C for 1 hour. Then the temperature was set to 90 °C under argon flow. The heating mantle was removed and solution of TMS₂S (0.42 mL, 2 mmol) in 10 mL of pre-dried ODE was injected into vigorously stirring lead oleate solution at 85 °C. After 1 minute 3 mL of oleic acid were injected and the reaction mixture was cooled down to room temperature with use of ice bath. QDs were washed three times with hexane/ethanol solvent/nonsolvent pair, each time with minimum amount of ethanol needed to precipitate QDs (1st step: 30 mL hexane/144 mL ethanol; 2nd step: 30/36; 3rd step: 15/17). Obtained QDs were dissolved in anhydrous hexane and filtered through 0.2 μ m PTFE filter. Absorption and photoluminescence spectra of the oleate-capped QDs were measured from the solution in tetrachloroethylene.

For the phase transfer ligand exchange, 10 mL of oleate-capped PbS CQDs dispersed in hexane (about 5 mg mL⁻¹) was poured on top 10 mL of a 50 mM MAI : PbI₂ = 1 : 1 solution in pre-dried *N*-methylformamide (NMF). The mixture was stirred for 12 h inside the nitrogen-filled glovebox followed by the phase transfer of PbS QDs to the NMF phase. The polar phase was rinsed two times with hexane (2 × 10 mL). The PbS/MAPbI₃ QDs were precipitated by adding 10 mL of acetone and immediate centrifugation at 4500 rpm for 5 min. The supernatant was



removed, and the pellet redispersed in 2,6-difluoropyridine (DFP) at 10 mg mL⁻¹ concentration. This solution was spin coated onto the lithographed electrode samples with 2000 rpm.

Optical measurements: aberration correction

For the quantitative measurement of the wavelength dependence of the photocurrent in Fig. 5a the chromatic aberration of the microscope objective had to be considered. Together with slight alignment imperfections, the aberration was found to give rise to lateral focus shifts up to a few 100 nm for excitation wavelengths above 720 nm. We used photocurrent maps at each wavelength to determine this shift and to correct the corresponding photocurrent values accordingly.

Author contributions

D. G. sample preparation, experiments, data analysis, image preparation; E. K. experimental contributions; D. N. D. and M. V. K. quantum dot synthesis; H. D., A. H. and J. R. K. conceptualization and supervision, J. R. K., D. G. and D. N. D. writing of the manuscript; all authors proofread the final manuscript.

Conflicts of interest

There are no conflicts to declare.

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